

Final datasheet  
CoolSiC™ 1200 V Schottky diode G5 : Silicon Carbide Diode with top side cooling and .XT technology

Features

- $V_{RRM} = 1200\text{ V}$
- $I_F = 20\text{ A}$
- No reverse recovery current / no forward recovery
- High surge current capability
- Temperature independent switching behavior
- Low forward voltage
- $dv/dt$  ruggedness
- Pb-free lead plating; RoHS compliant
- .XT interconnection technology for best-in-class thermal performance

Potential applications

- EV Charging
- DIN Rail & Rack Mount (Power Supply)
- Commercial Lighting Fixture

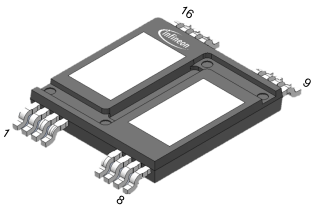
Product validation

- Qualified for industrial applications according to the relevant tests of JEDEC47/20/22

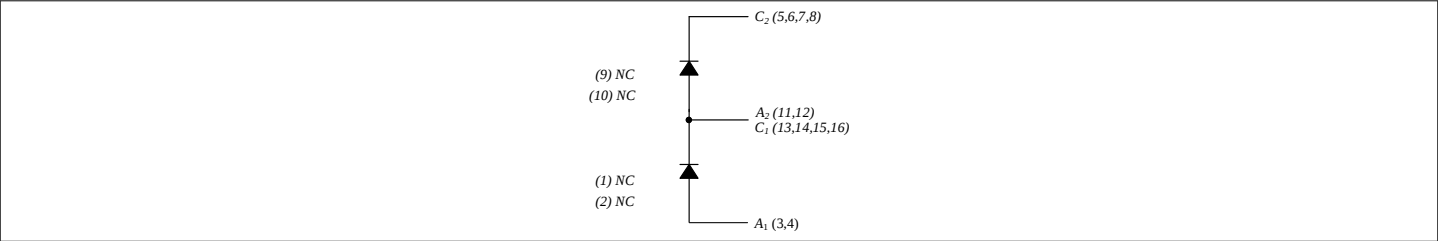
Description

Pin definition:

- 13-16 & Case 1 – Cathode 1 ( $C_1$ )
- 1, 2 – not connected (NC)
- 3-4 – Anode 1 ( $A_1$ )
- 5-8 & Case 2 – Cathode 2 ( $C_2$ )
- 9, 10 – not connected (NC)
- 11-12 – Anode 2 ( $A_2$ )



- Lead-free
- Green
- Halogen-free
- RoHS



| Type          | Package         | Marking |
|---------------|-----------------|---------|
| IDSQ20G120C5D | PG-HDSOP-16-U03 | D2012C5 |



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## 1 Package

**Table 1** Characteristic values

| Parameter                               | Symbol        | Note or test condition                                | Values |      |      | Unit |
|-----------------------------------------|---------------|-------------------------------------------------------|--------|------|------|------|
|                                         |               |                                                       | Min.   | Typ. | Max. |      |
| Storage temperature                     | $T_{stg}$     |                                                       | -55    |      | 150  | °C   |
| Soldering temperature                   | $T_{sold}$    | Reflow soldering (MSL2 according to JEDEC J-STD-020)  |        |      | 260  | °C   |
| Thermal resistance, junction-ambient    | $R_{th(j-a)}$ |                                                       |        |      | 62   | K/W  |
| Diode thermal resistance, junction-case | $R_{th(j-c)}$ |                                                       |        | 0.32 | 0.41 | K/W  |
| Comparative Tracking Index              | $CTI$         | IEC 60112 (material group 1 according to IEC 60664-1) | 600    |      |      | V    |

## 2 SiC Diode

**Table 2** Maximum rated values

| Parameter                                                     | Symbol       | Note or test condition                            |                       | Values | Unit             |
|---------------------------------------------------------------|--------------|---------------------------------------------------|-----------------------|--------|------------------|
| Repetitive peak reverse voltage                               | $V_{RRM}$    | $T_{vj} \geq 25\text{ °C}$                        |                       | 1200   | V                |
| Continuous forward current for $R_{th(j-c,max)}$              | $I_F$        |                                                   | $T_c = 25\text{ °C}$  | 72     | A                |
|                                                               |              |                                                   | $T_c = 135\text{ °C}$ | 34     |                  |
|                                                               |              |                                                   | $T_c = 159\text{ °C}$ | 20     |                  |
| Surge repetitive forward current, sine halfwave <sup>1)</sup> | $I_{F,RM}$   | $t_p = 10\text{ ms}$                              | $T_c = 25\text{ °C}$  | 80     | A                |
|                                                               |              |                                                   | $T_c = 100\text{ °C}$ | 60     |                  |
| Surge non-repetitive forward current, sine halfwave           | $I_{F,SM}$   | $t_p = 10\text{ ms}$                              | $T_c = 25\text{ °C}$  | 139    | A                |
|                                                               |              |                                                   | $T_c = 150\text{ °C}$ | 113    |                  |
| Non-repetitive peak forward current                           | $I_{F,max}$  | $T_c = 25\text{ °C}, t_p = 10\text{ }\mu\text{s}$ |                       | 730    | A                |
| $I^2t$ -value                                                 | $\int I^2 t$ | $t_p = 10\text{ ms}$ <sup>2)</sup>                | $T_c = 25\text{ °C}$  | 97     | A <sup>2</sup> s |
|                                                               |              |                                                   | $T_c = 150\text{ °C}$ | 64     |                  |
| Diode dv/dt ruggedness                                        | $dv/dt$      | $V_R = 0\ldots 960\text{ V}$                      |                       | 150    | V/ns             |
| Avalanche energy, single pulse                                | $E_{AS}$     | $I_D = 20\text{ A}, L = 0.29\text{ mH}$           |                       | 57     | mJ               |
| Power dissipation for $R_{th(j-c,max)}$                       | $P_{tot}$    |                                                   | $T_c = 25\text{ °C}$  | 365    | W                |
|                                                               |              |                                                   | $T_c = 100\text{ °C}$ | 182    |                  |

1) Not subject to production test. The test was performed with 20k pulses (half-wave rectified sine with 10 ms period).

2) sine halfwave

**Table 3**                      **Characteristic values**

| Parameter                    | Symbol   | Note or test condition                                                                        |                         | Values |      |      | Unit       |
|------------------------------|----------|-----------------------------------------------------------------------------------------------|-------------------------|--------|------|------|------------|
|                              |          |                                                                                               |                         | Min.   | Typ. | Max. |            |
| DC blocking voltage          | $V_{DC}$ | $I_R = 500 \mu A$                                                                             |                         | 1200   |      |      | V          |
| Diode forward voltage        | $V_F$    | $I_F = 20 A$                                                                                  | $T_{vj} = 25 ^\circ C$  |        | 1.45 | 1.8  | V          |
|                              |          |                                                                                               | $T_{vj} = 125 ^\circ C$ |        | 1.69 |      |            |
|                              |          |                                                                                               | $T_{vj} = 150 ^\circ C$ |        | 1.8  |      |            |
| Reverse current              | $I_R$    | $V_R = 1200 V$                                                                                | $T_{vj} = 25 ^\circ C$  |        | 10   | 160  | $\mu A$    |
|                              |          |                                                                                               | $T_{vj} = 150 ^\circ C$ |        | 58   |      |            |
| Total capacitive charge      | $Q_C$    | $V_R = 800 V, T_{vj} = 25 ^\circ C \text{ \& } 150 ^\circ C,$<br>$Q_C = \int_0^{V_R} C(V) dV$ |                         |        | 96   |      | nC         |
| Total capacitance            | $C$      | $f = 100 \text{ kHz}$                                                                         | $V_R = 1 V$             |        | 1236 |      | pF         |
|                              |          |                                                                                               | $V_R = 400 V$           |        | 87   |      |            |
|                              |          |                                                                                               | $V_R = 800 V$           |        | 70   |      |            |
| Virtual junction temperature | $T_{vj}$ |                                                                                               |                         | -55    |      | 175  | $^\circ C$ |

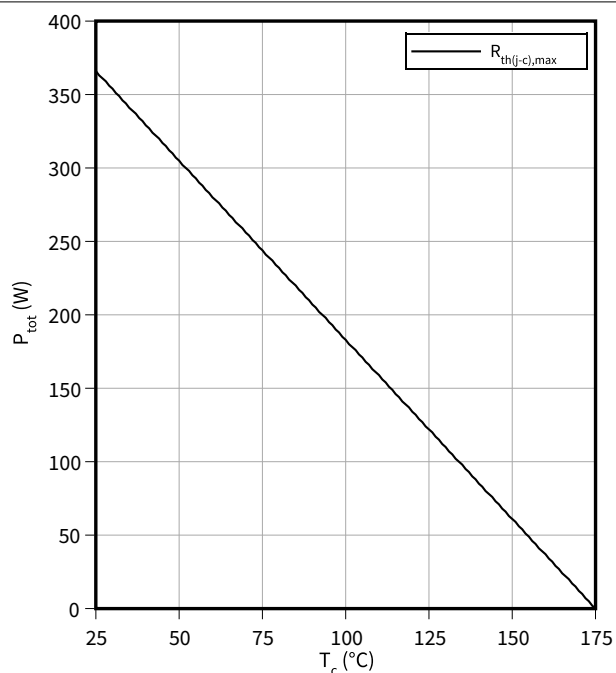
**Note:**                      *For optimum lifetime and reliability, Infineon recommends operating conditions that do not exceed 80% of the maximum ratings stated in this datasheet.*  
*Characteristic at  $T_{vj} = 25 ^\circ C$ , unless otherwise specified.*

### 3 Characteristics diagrams

#### Power dissipation as function of case temperature

$$P_{\text{tot}} = f(T_c)$$

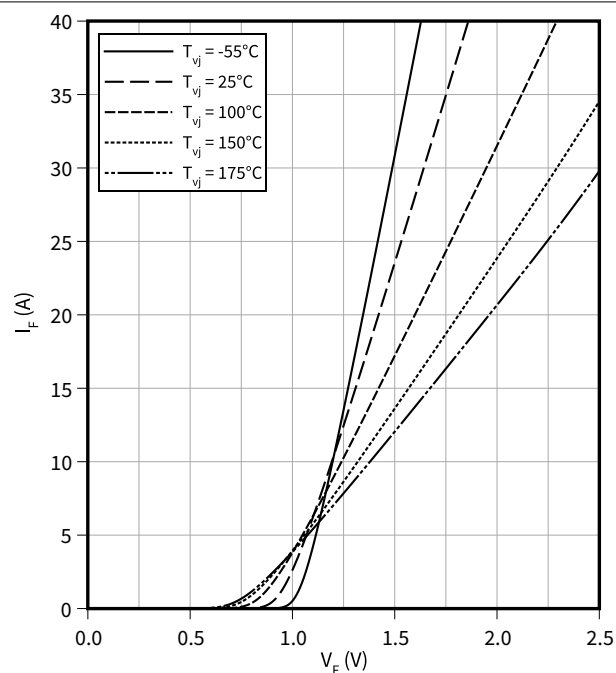
$$T_{vj} \leq 175^\circ\text{C}$$



#### Typical forward characteristics

$$I_F = f(V_F)$$

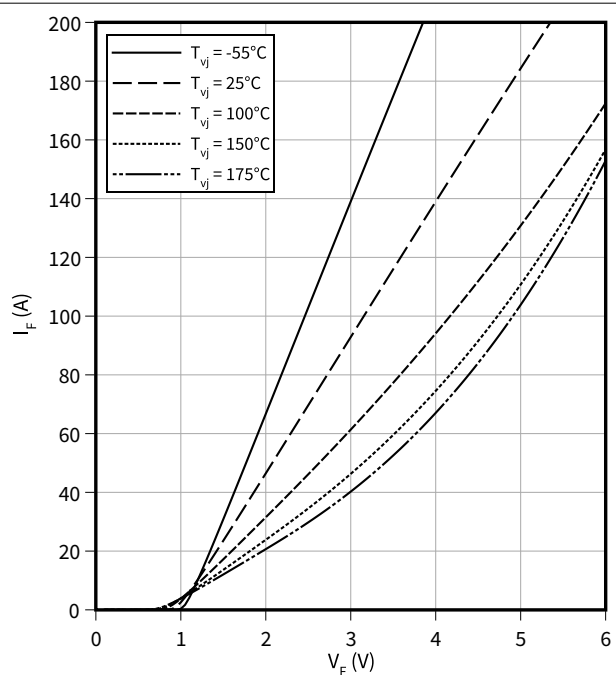
$$t_p = 10 \mu\text{s}$$



#### Typical forward characteristics in surge current

$$I_F = f(V_F)$$

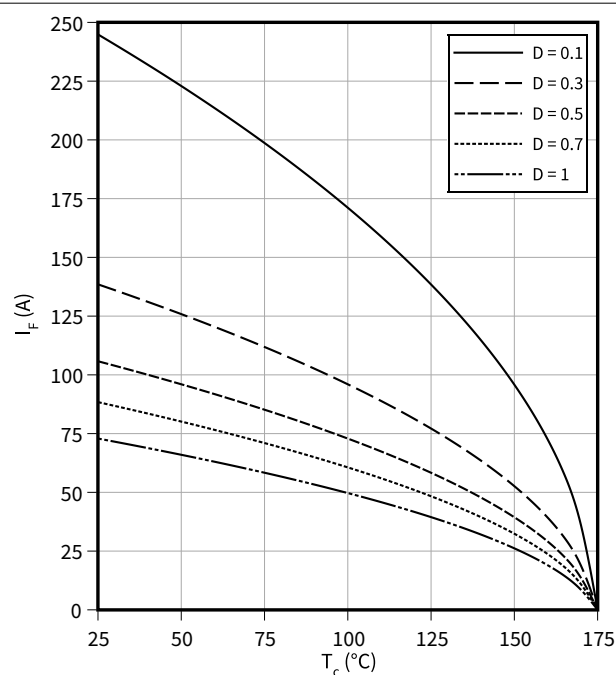
$$t_p = 10 \mu\text{s}$$



#### Diode forward current as function of temperature

$$I_F = f(T_c)$$

$$T_{vj} \leq 175^\circ\text{C}$$

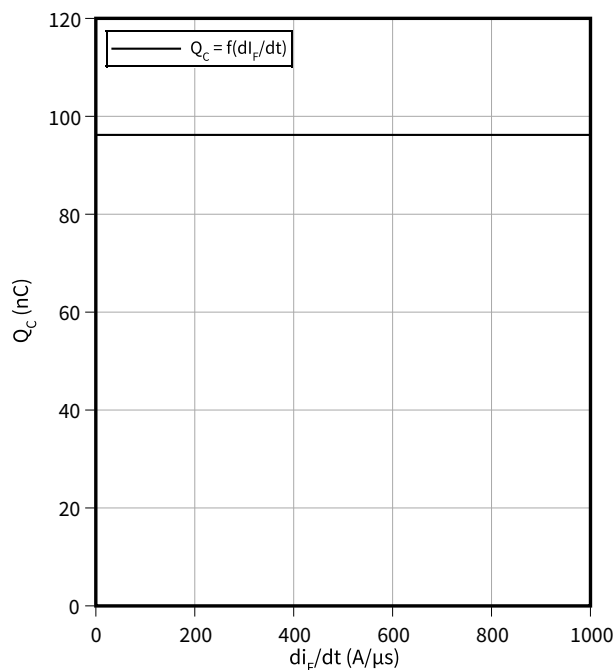


**3 Characteristics diagrams**

**Typical capacitive charge as function of current slope**

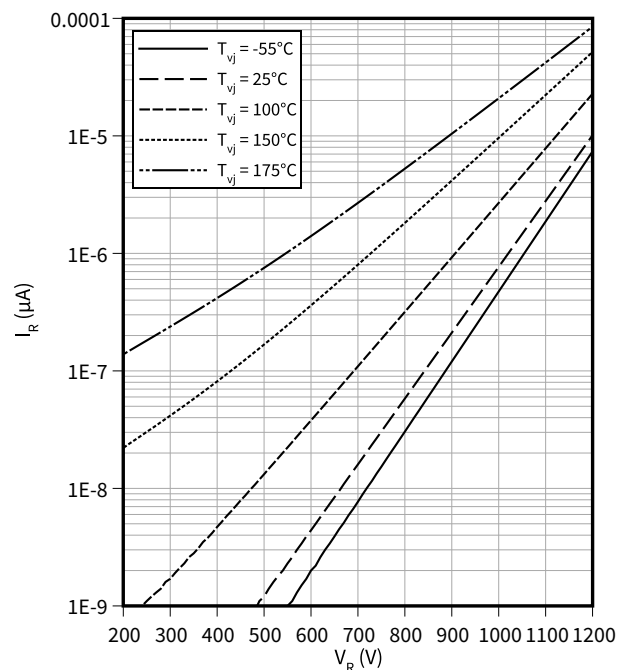
$$Q_C = f(di_F/dt)$$

$T_{vj} = 25^\circ\text{C}$ ,  $V_R = 800\text{ V}$



**Typical reverse characteristics**

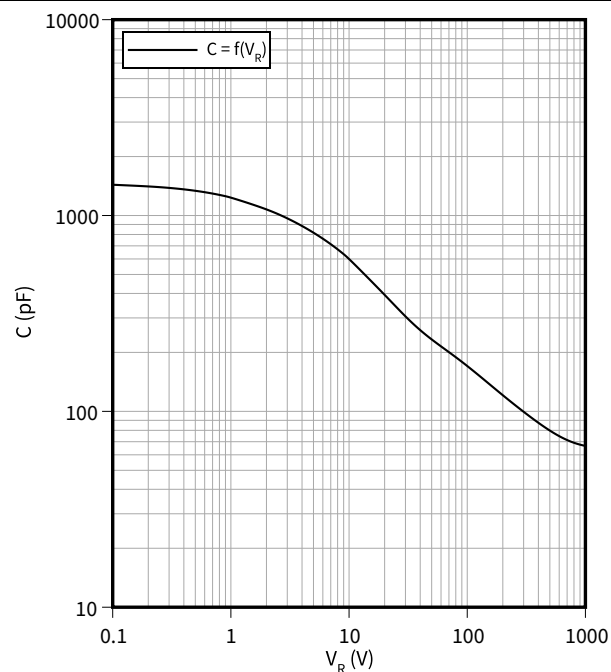
$$I_R = f(V_R)$$



**Typical capacitance as function of reverse voltage**

$$C = f(V_R)$$

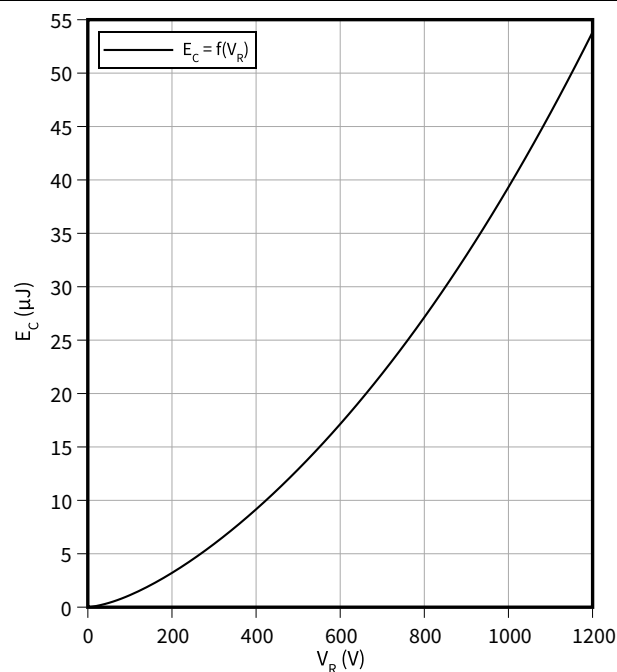
$T_{vj} = 25^\circ\text{C}$ ,  $f = 100\text{ kHz}$



**Typical capacitively stored energy as function of reverse voltage**

$$E_C = f(V_R)$$

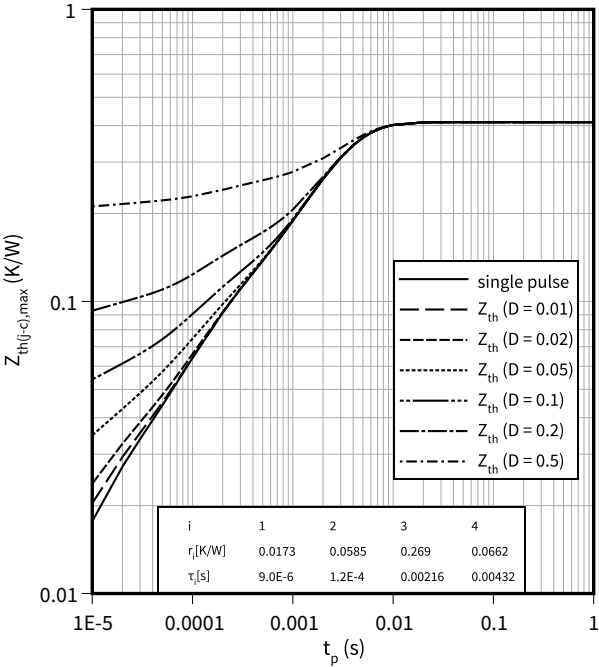
$f = 100\text{ kHz}$



3 Characteristics diagrams

Max. transient thermal impedance

$Z_{th(j-c),max} = f(t_p)$   
 $D = t_p/T$



4 Package outlines

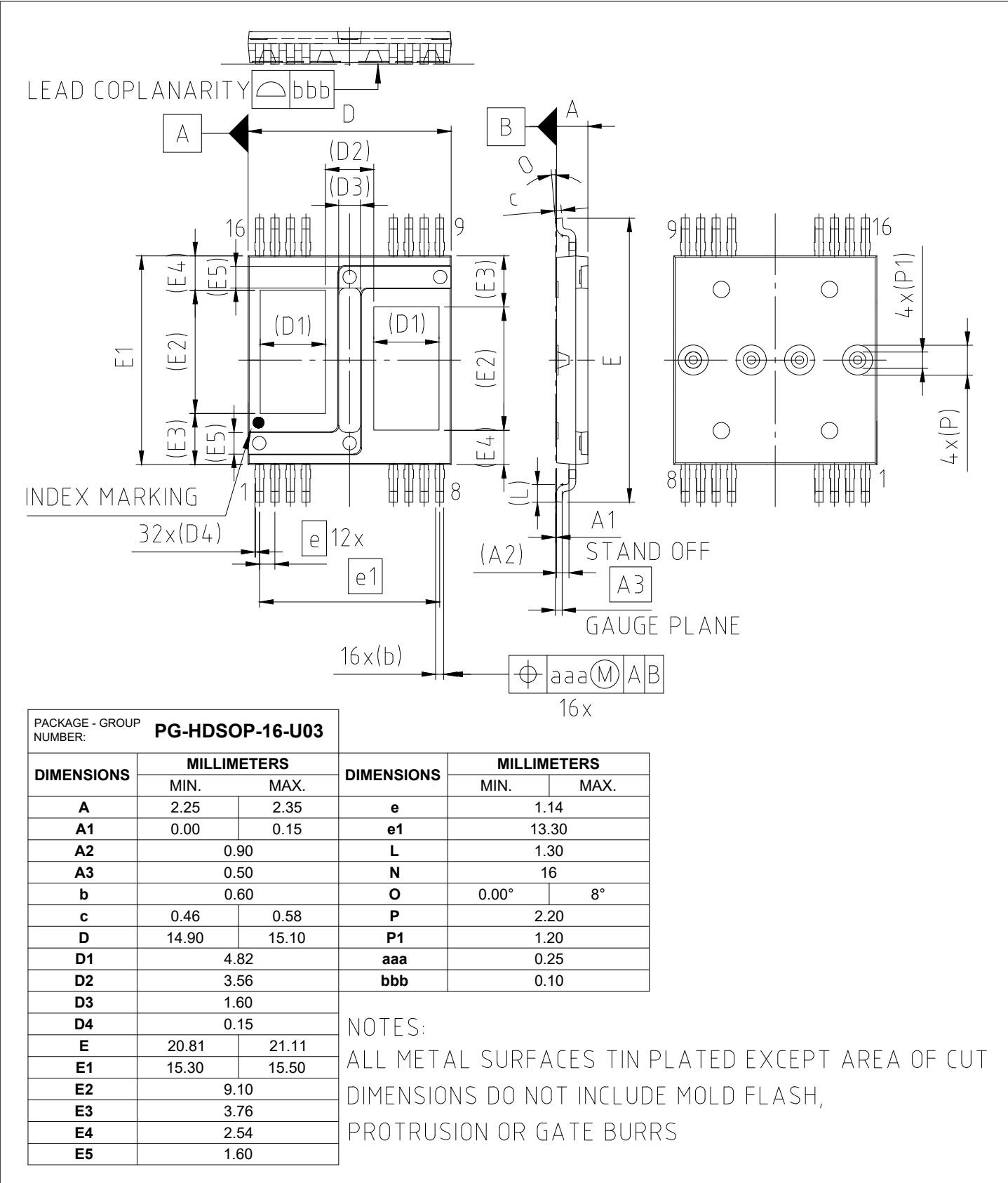


Figure 1

## Revision history

| Document revision | Date of release | Description of changes                                                          |
|-------------------|-----------------|---------------------------------------------------------------------------------|
| 0.10              | 2024-01-24      | Target datasheet                                                                |
| 0.20              | 2024-11-14      | Updated Avalanche energy, single pulse $E_{AS}$ in Table 2<br>Editorial changes |
| 0.30              | 2025-04-03      | Preliminary datasheet                                                           |
| 1.00              | 2026-06-25      | Final datasheet                                                                 |

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